



ISSM (International Symposium on Semiconductor Manufacturing)



History of ISSM (International Symposium on Semiconductor Manufacturing)

ISSM's mission is to achieve the continued prosperity of the semiconductor industry by bringing about breakthroughs in semiconductor manufacturing technologies through networking between engineers in research and development fields and their counterparts in the manufacturing field.

Year	1992	1993	1994	1995	1996	1997	1998	1999	2000	2001	2002	2003	2004	2005	2006	2007	2008	2009	2010	2011	2012	2013	2014	2015	2016	2017	2018	2019	2020	2022	2024
Place	Tokyo	Austin	Tokyo	Austin	Tokyo	SFO	Tokyo	SFO	Tokyo	San Jose	Tokyo	San Jose	Tokyo	San Jose	Tokyo	Santa Clara	Tokyo	Berlin with ASMC	Tokyo	Hsinchu with e-MDC	Tokyo	Hsinchu with e-MDC	Tokyo	Taipei with e-MDC	Tokyo	Hsinchu with e-MDC	Tokyo	Hsinchu with e-MDC	Tokyo	Tokyo	Tokyo
Attendance	NA	NA	NA	NA	1000	506	750	642	762	336	427	381	414	280	482	242	365	Cancelled	259	319	299	260	209	195	212	170	225	170	273	254	241
Number of Countries Represented					10	16	10	14	21	15	14	15	16	14	12	14	13		10	5	11	5	7	6	10	6	9	NA	5	13	5
# of submitted abstract (CFP)	Invited Only	Invited Only	52	102	100	260	180	223	178	309	220	278	201	221	181	191	126		78	62	74	46	54	26	59	28	60	NA	42	51	38
# of country for CFP			NA	NA	NA	17	13	11	11	12	14	18	17	14	12	13	12		7	4	9	8	7	4	11	6	9	NA	6	12	4
# of affiliation for CFP			NA	NA	NA	NA	NA	72	65	83	69	77	64	76	64	71	63		34	22	28	19	30	13	36	15	32	NA	31	39	25
Selected paper total			42	71	79	95	113	110	103	127	117	125	127	117	116	124	102		69	55	60	35	46	24	53	25	55	NA	39	37	36
Acceptance rate			81%	70%	50%	32%	49%	41%	60%	41%	53%	45%	63%	53%	64%	65%	81%		88%	89%	81%	76%	85%	92%	90%	89%	92%	NA	93%	73%	95%
Presented																															
Oral paper			30	50	47	64	57	66	40	69	58	63	64	61	63	58	60		45	52	34	35	32	24	44	25	44	17	37	32	30
Poster			12	21	32	31	56	44	63	58	59	62	63	56	53	54	33		20	3	21	0	14	0	9	0	11	2	0	5	6
Keynote/Invited					11	6	7	4	7	7	9	9	5	6	6	8	6		7	7	14	11	7	6	9	7	10	6	10	13	15

About ISSM

<https://issm.semiconportal.net/about-issm/>



ISSM Organization as of August 8, 2025

Organizing Committee

Chairman: Shozo Saito, Nippon Electronic Device Industry Association(NEDIA)
Vice Chairman: Shuichi Inoue, ATONARP INC.
Junichi Wada, Kioxia Corporation
Michihiro Inoue, minimalFab Promoting Organization
Masayoshi Tarutani, Mitsubishi Electric Corporation
Atsuyoshi Koike, Rapidus Corporation
Yasuntoshi Okuno, SCREEN Holdings Co., Ltd.
Hayato Iwamoto, Sony Semiconductor Solutions Corporation
Sumi Segawa, Tokyo Electron Ltd.
Hiroaki Kato, TOSHIBA ELECTRONIC DEVICES & STORAGE Corporation
Tomoyuki Sasaki, Tower Partners Semiconductor Co., Ltd. (TPSCo)

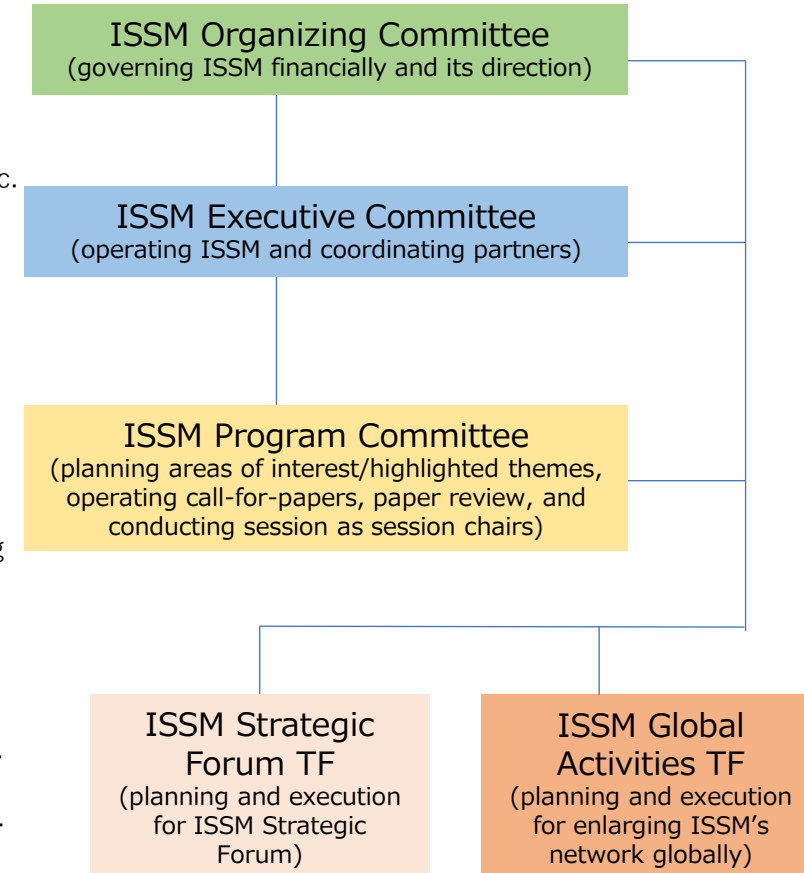
Executive Committee

Chairman:
Hiroaki Kato, TOSHIBA ELECTRONIC DEVICES & STORAGE Corporation
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Hiroshi Akahori, Rapidus Corporation
Hiroyuki Mori, Renesas Electronics Corporation
Takashi Shimane, Rohm Co., Ltd.
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Kiyoshi Watanabe, Semiconductor Equipment Association of Japan (SEAJ)
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Takeshi Hattori
Toshiyuki Uchino

Program Committee

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Sumika Arima, University of Tsukuba

ISSM Organization





Previous ISSM Report

The 30th ISSM 2024 Summary

Date: Monday, December 9 and Tuesday, December 10, 2024

Venue: KFC Hall, Ryogoku, Tokyo, Japan

IEEE: Technical Sponsorship



ISSM 2024

ISSM has been contributing progress of semiconductor manufacturing technologies from a scientific perspective and has been conducting activities to share medium- and long-term improvement measures for common manufacturing issues and short-term and practicable solutions. ISSM2024 marks the 30-year anniversary. Recently, with the participation of material and equipment manufacturers, which are Japan's strength, in addition to device manufacturers, ISSM has expanded its presence as the only conference to discuss production and manufacturing technologies from process and equipment control to materials and devices, as well as plant operations, based on highly dimensional science driven by big data. ISSM aims to "design the future semiconductor manufacturing," and will boldly embrace the movement of new changes in semiconductor manufacturing and lead the innovative technologies in semiconductor production more than ever before.

Currently, there are dramatical changes in terms of economic security internationally, such as the restructure of the supply chain of cutting-edge logic semiconductor chips and the emergence of a foundry by a foundry. Under international cooperation, new factories are being actively constructed in Japan and other countries around the world. In order to realize the miniaturization of transistors with a secure operating margin, research and development are progressing on new device physics and the introduction of new materials are advancing. With the time-to-market supply of AI chips as a competitive advantage in the market, a new challenge to ultra-short TAT production is garnering attention. The transition from conventional semiconductor manufacturing mixed batch and wafer processes to full single-wafer manufacturing has become a hot topic, and the adoption of latest trends and innovative technologies, such as 3D package, chiplet integration and their manufacturing technologies, is also urgently needed.

Furthermore, in the green transformation of semiconductor factories to realize a decarbonized society, it is necessary to evolve into a line reconstruction and operation mode for manufacturing new structure devices by introducing energy-saving process equipment and new materials. In addition to the new directions mentioned above, common discussions and interactions among companies, academic societies, and research institutes included in the semiconductor value chain are becoming more significant for the utilization of generative AI beyond the conventional approach and semiconductor chip manufacturing in smart factories.

ISSM provides a forum for researchers and engineers to develop and discuss the direction, activities, and operations of production technologies ahead of the future by combining a bird's-eye view of broad industrial and technological trends with a management perspective.

◆ISSM 2024 areas of interest **Areas of Interest**

Abstract will be accepted for each of following areas of interest.

Fab Management

- * Factory Design (FD)
- * Manufacturing Strategy (MS)
- * Manufacturing Control and Execution (MC)
- * Environment, Safety and Health, Carbon Neutral (ES)
- * Intelligent Data Management (ID)

Process Integration

- * Process/Material Optimization (PO)
- * Yield Enhancement and Methodology (YE)
- * Ultraclean Technology and Contamination Control (UC)
- * Process Monitoring and Control Method (PC)
- * Process/Metrology Equipment (PE)
- * Design for Manufacturing (DM)
- * Manufacturing Technology for Variety Devices (VD)

3D, Chiplets & Advanced Packaging

- *3D, Chiplet, and Advanced Packaging Technology (TP)



ISSM 2024 Keynote Speakers

Semiconductor Ecosystem : India-Japan Strategic Partnership

His Excellency Sibi George, Ambassador of India to Japan
Ambassador of India to Japan



Japan's semiconductor strategy

Mr. Hidemichi Shimizu
Director of Device Industry & Semiconductor Strategy Office, Commerce and Information on Policy Bureau,
Ministry of Economy, Trade and Industry



AI and Semiconductor Manufacturing – opportunities and challenges

Dr. Daisuke Okanohara
Chief Executive Researcher, Preferred Networks, Inc.



2nm Node Interconnect Technology and R&D toward 1.4nm Node and Beyond

Dr. Takeshi Nogami
Principal Research Staff Member, Lead Technologist / Strategist for BEOL Extendibility, IBM Research



Research and development in NTT Basic Research Laboratories towards IOWN and beyond

Dr. Katsuya Oguri
NTT Basic Research Laboratories, Nippon Telegraph and Telephone Corporation



Highly Accurate Via Formation Technologies for Advanced Packaging Process Using Plasma Dry Etching

Dr. Yasuhiro Morikawa
Manager, PE-Semiconductor Technology Research Department Institute of Advanced Technology, Research &
Development HQ, ULVAC, Inc.





ISSM 2024 Tutorial Speakers, Special Session

Tutorial Speakers

50 years of thin film processing innovation in SC industry

Prof. Christophe Vallée
Professor, University at Albany, CNSE



Computational materials science studies on the search for potential dopant candidates.

Prof. Yasuteru Shigeta
Vice president and Executive Director for Research
Professor of Center for Computational Sciences, University of Tsukuba



The History and Future of Semiconductor Lithography: New Prospects Beyond the Limits of Pattern Shrinking

Dr. Tatsuhiko Higashiki
Assistant to General Manager, Research Strategy Planning Office, Frontier Technology R&D Institute, Kioxia



Special Speaker

Improving energy efficiency and development efficiency

Prof. Tadahiro Kuroda
University Professor, Office of University Professor, The University of Tokyo,
Chancellor, Prefectural University of Kumamoto





ISSM 2024 Panel Discussion

Panel Discussion on organized by ISSM committee

- Human resources to vitalize Japan's semiconductor industry

Moderator:

Shuichi Inoue, ATONARP INC.

Panelists:

Tadahiro Kuroda, The University of

Tokyo/Prefectural University of Kumamoto

Kazunori Kato, Advanced Interface Technology Corporation

Kenji Miyake, Office Miyake

Shin-ichi Imai, Hitachi High-Tech

The screenshot shows a presentation slide for the ISSM 2024 Special Session Panel Discussion. The slide features the ISSM logo, the title 'International Symposium on Semiconductor Manufacturing (ISSM)', and the session title 'Special Session Panel Discussion' dated 'Tuesday, December 10'. Below the title are five portraits of the participants, each with their name and affiliation. The participants are Shin-ichi Imai (Hitachi High-Tech Corporation, ISSM Program Committee Chair), Kenji Miyake (Office Miyake), Kazunori Kato (Advanced Interface Technology Corporation (AIT)), Tadahiro Kuroda (The University of Tokyo/Prefectural University of Kumamoto), and Shuichi Inoue (ATONARP Inc., ISSM Organizing Committee Vice Chair). Below the slide is a photograph of the five participants seated on a stage during the panel discussion.

International Symposium on Semiconductor Manufacturing (ISSM)

Special Session Panel Discussion

Tuesday, December 10

				
Shin-ichi Imai Hitachi High-Tech Corporation ISSM Program Committee Chair	Kenji Miyake Office Miyake	Kazunori Kato Advanced Interface Technology Corporation (AIT)	Tadahiro Kuroda The University of Tokyo/ Prefectural University of Kumamoto	Shuichi Inoue ATONARP Inc. ISSM Organizing Committee Vice Chair

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ISSM2024 Invited Speakers

ETDM2024

EDTM-215 : Reduction of contact resistance to PVD-MoS₂ film using aluminum–scandium alloy (AlSc) edge contact

Prof. Hitoshi Wakabayashi, Institute of Science Tokyo

EDTM-496 : SiC Materials and Devices for Future Green Society

Prof. Shin-ichi Nishizawa, Kyushu University

EDTM-470 : Intermetallic compounds for future ULSI metallization

Prof. Junichi Koike, Tohoku University

IITC2024

IITC-11.5 : Bonding induced distortion in wafer-to-wafer bonding applications: how the scanner and Yieldstar can enable 3D integration

V.M. Blanco Carballo, IMEC

IITC-11.4 : Study and Control of the Distortion Induced by the Bonding Process for BSPDN Approaches

Karine Abadie, CEA-Leti

ISSM2024

PC-042 : Understanding Surface Reaction in PECVD Process by Combining In-situ Monitoring and Machine Learning

Makoto Sekine, Takayoshi Tsutsumi, Nagoya University



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Hitachi High-Tech Corporation

HORIBASTEC

JSR Corporation

KFMI

KLA

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KOKUSAI ELECTRIC

Lasertec

MERCK

Nikon

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NISSAN ION EQUIPMENT CO., LTD.

NUFLARE

ROHM
SEMICONDUCTOR

SCREEN

ShinEtsu

SUMCO CORPORATION

SUMITOMO BAKELITE CO., LTD.

STELLA
CHEMICAL

Tama
CHEMICALS

tok

TOMOE

'TORAY'

TPSCo

ULVAC

USJC

Nissan Chemical
CORPORATION
IK INABATA



ISSM2024 Award Winners

★The papers of ISSM Award winners submitted to IEEE journal, Transactions on Semiconductor Manufacturing (TSM) are available on IEEE website.

Best of the Best Paper Award

PC-033 Rapid and Flexible Yield Analysis Powered by Large Language Model / Yutaka Sawai, Rohm

Best Papers Award

- MC-044★ Deep Reinforcement Learning-based Effective Training Design for Dynamic Machine Allocation with Case Study of a Semiconductor Tool Group / Hsin-Tzu Hsu, National Taiwan University
- PO-014★ Optimal Design of Wet Etching Bath for 3D Flash Memories Using Multi-Objective Bayesian Optimization / Miyuki Kouda, Kioxia
- PO-023★ Space-filling experimental design for efficient Bayesian optimization / Shigeru Kinoshita, Kioxia
- PO-007★ Vacancy-type defects in thin HfO₂ layers probed by monoenergetic positron beams / Akira Uedono, University of Tsukuba
- PO-021 Characterization of Hydrogen Desorption and Charge Traps in Silicon Nitride Films / Kiyoteru Kobayashi, ESCO, Ltd.
- PO-032★ Improvement of P-base contact resistance in power MOSFETs and its impact on avalanche capability / Keisuke Miyamoto, TOSHIBA ELECTRONIC DEVICES & STORAGE
- PC-034★ Proactive Control Setting of Real Time Equipment Monitoring for Raising End-of-Line Process Performance / Kuan-Chun Lin, National Taiwan University
- PO-046★ Ar/N₂ gas flow rate dependence on the ferroelectric HfN_{1.15} thin film formation by ECR-plasma sputtering / KANGBAI LI, Institute of Science Tokyo
- PO-024 Investigation on the Relationship Etching Rate and Photoresist Surface Temperature during Reactive Atmospheric-pressure Thermal Plasma Jet Irradiation/ Kyohei Matsumoto, Hiroshima University
- YE-013 Accuracy Improvement of Chip-on-Wafer Surface Defect Inspection by Deep Learning / Kazuto Kawakatsu, Sony Semiconductor Solutions
- PC-015 Virtual Metrology using Transfer Learning with Domain Knowledge / Masaaki Takada, Toshiba
- YE-018★ Evaluation of Metal Contamination Behavior on Silicon Dioxide Surface Rinsed with Deionized Water Containing Ultra-trace Metal in Single-wafer Cleaning Process/ Kyohei Tsutano, ORGANO
- PC-043★ Fast Temperature Control in Semiconductor Vertical Furnace with Time-Optimal Control and Iterative Experiments / Christian Milleneuve Budiono, The University of Tokyo
- PC-030★ Case Study on Modeling of Multiple Process Using Intermediate Variables for Digital Twin Modeling of a Semiconductor Manufacturing/ Ryosuke Okachi, Toyota Central R&D Labs., Inc.

Student Award

PC-043 Fast Temperature Control in Semiconductor Vertical Furnace with Time-Optimal Control and Iterative Experiments / Christian Milleneuve Budiono, The University of Tokyo

Best Student Poster Award

PO-040 Strong amorphization in In₂O₃-based flexible transparent conductive films by hydrogen incorporation and higher sputtering pressure / Kanta Kibishi, Kogakuin University



International Symposium on Semiconductor Manufacturing (ISSM)

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